



3.3V LVPECL 1:4 Clock Fanout Buffer

AK8181A

Features

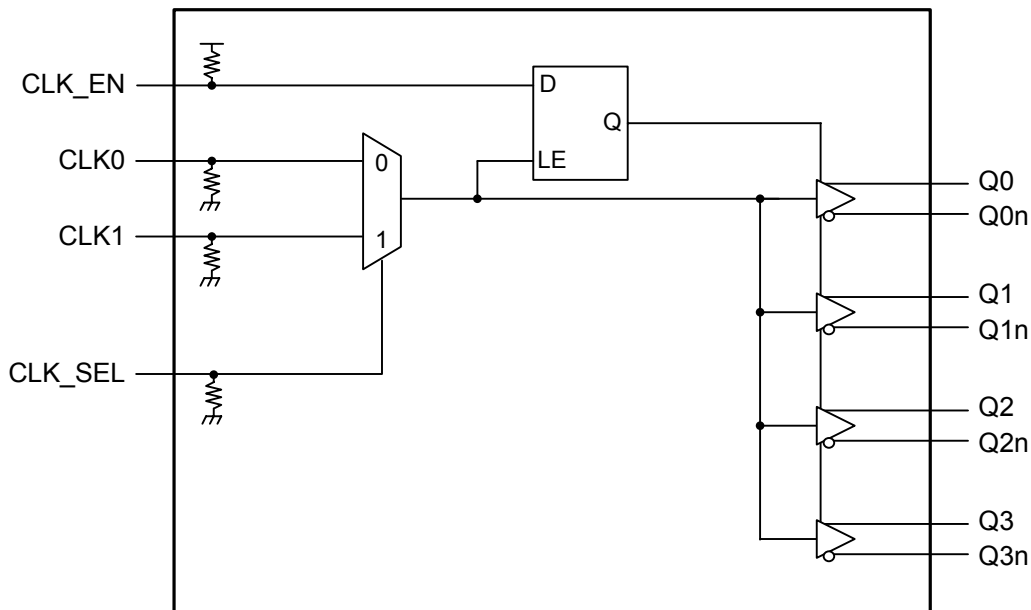
- Four differential 3.3V LVPECL outputs
- Selectable two LVTTTL/LVCMOS inputs
- Clock output frequency up to 266MHz
- Output skew : 30ps maximum
- Part-to-part skew : 200ps maximum
- Propagation delay : 1.4ns maximum
- Additive phase jitter(RMS) : < 0.06ps(typical)
- Operating Temperature Range: -40 to +85°C
- Package: 20-pin TSSOP (Pb free)
- Pin compatible with ICS8535I-01

Description

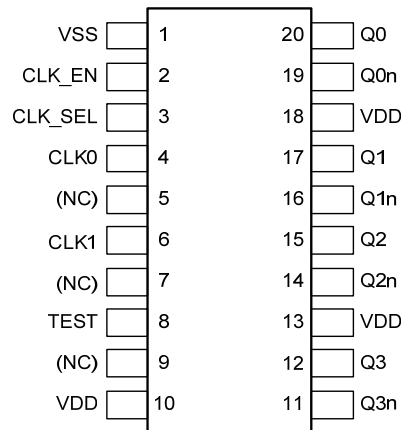
The AK8181A is a member of AKM's LVPECL clock fanout buffer family designed for telecom, networking and computer applications, requiring a range of clocks with high performance and low skew. The AK8181A distributes 4 buffered clocks.

AK8181A are derived from AKM's long-term-experienced clock device technology, and enable clock output to perform low skew. The AK8181A is available in a 20-pin TSSOP package.

Block Diagram



Pin Descriptions



Package: 20-Pin TSSOP (Top View)

Pin No.	Pin Name	Pin Type	Pullup down	Description
1	VSS	PWR	--	Negative supply
2	CLK_EN	IN	PU	Synchronizing clock output enable (LVCMOS/LVTTL) H: clock outputs follow clock input. L: Q outputs are forced low, Qn outputs are forced high.
3	CLK_SEL	IN	PD	CLK Select Input (LVCMOS/LVTTL) H: selects CLK1 input L: selects CLK0 input
4	CLK0	IN	PD	LVCMOS/LVTTL Clock Input
5	NC	--	--	No connect
6	CLK1	IN	PD	LVCMOS/LVTTL Clock Input
7	NC	--	--	No connect
8,	TEST	--	--	Factory use. Internally pulled down. Leave open or tied to VSS.
9	NC	--	--	No connect
10	VDD	PWR	--	Power supply
11, 12	Q3n, Q3	OUT	--	Differential clock output pair (LVPECL)
13	VDD	PWR	--	Power supply
14, 15	Q2n, Q2	OUT	--	Differential clock output (LVPECL)
16, 17	Q1n, Q1	OUT	--	Differential clock output (LVPECL)
18	VDD	PWR	--	Power supply
19, 20	Q0n, Q0	OUT	--	Differential clock output (LVPECL)

Ordering Information

Part Number	Marking	Shipping Packaging	Package	Temperature Range
AK8181A	AK8181A	Tape and Reel	20-pin TSSOP	-40 to 85 °C

Absolute Maximum Rating

Over operating free-air temperature range unless otherwise noted ⁽¹⁾

Items	Symbol	Ratings	Unit
Supply voltage ⁽²⁾	VDD	-0.3 to 4.6	V
Input voltage ⁽²⁾	V _{in}	-0.3 to VDD+0.3	V
Input current (any pins except supplies)	I _{IN}	±10	mA
Storage temperature	T _{stg}	-55 to 130	°C

Note

(1) Stress beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under “Recommended Operating Conditions” is not implied. Exposure to absolute-maximum-rating conditions for extended periods may affect device reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

(2) VSS=0V



ESD Sensitive Device

This device is manufactured on a CMOS process, therefore, generically susceptible to damage by excessive static voltage. Failure to observe proper handling and installation procedures can cause damage. AKM recommends that this device is handled with appropriate precautions.

Recommended Operation Conditions

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Operating temperature	T _a		-40		85	°C
Supply voltage ⁽¹⁾	VDD	VDD±5%	3.135	3.3	3.465	V

(1) Power of 3.3V requires to be supplied from a single source. A decoupling capacitor of 0.1μF for power supply line should be located close to each VDD pin.

Pin Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Input Capacitance	C _{IN}			4		pF
Input Pullup Resistor	R _{PU}			51		kΩ
Input Pulldown Resistor	R _{PD}			51		kΩ

DC Characteristics

All specifications at VDD= 3.3V±5%, Ta: -40 to +85°C, unless otherwise noted

Parameter		Symbol	Conditions	MIN	TYP	MAX	Unit
Input High Voltage	CLK0, CLK1	V _{IH}		2.0		VDD+0.3	V
	CLK_EN, CLK_SEL			2.0		VDD+0.3	
Input Low Voltage	CLK0, CLK1	V _{IL}		-0.3		1.3	V
	CLK_EN, CLK_SEL			-0.3		0.8	
Input High Current	CLK0, CLK1, CLK_SEL	I _H	V _{in} =VDD			150	μA
	CLK_EN		V _{in} =VDD			5	μA
Input Low Current	CLK0, CLK1, CLK_SEL	I _L	V _{in} =VSS	-5			μA
	CLK_EN		V _{in} =VSS	-150			μA
Output High Voltage ⁽¹⁾		V _{OH}		VDD-1.4		VDD-0.9	V
Output Low Voltage ⁽¹⁾		V _{OL}		VDD-2.0		VDD-1.7	V
Peak-to-Peak Output Voltage Swing ⁽¹⁾		V _{SWING}		0.6		1.0	V
Supply Current		I _{DD}			35	50	mA

(1) .Outputs terminated with 50Ω to VDD-2V.

AC Characteristics

All specifications at VDD= 3.3V±5%, Ta: -40 to +85°C, unless otherwise noted

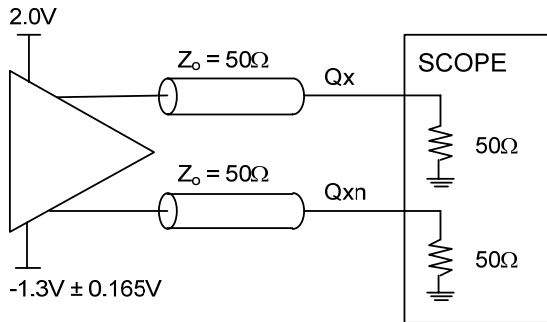
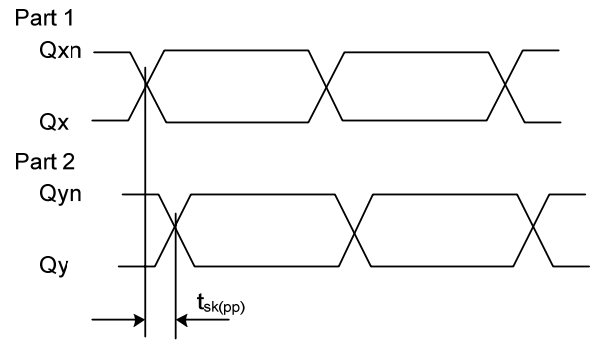
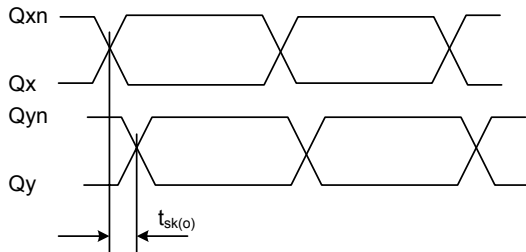
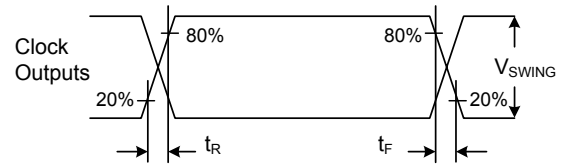
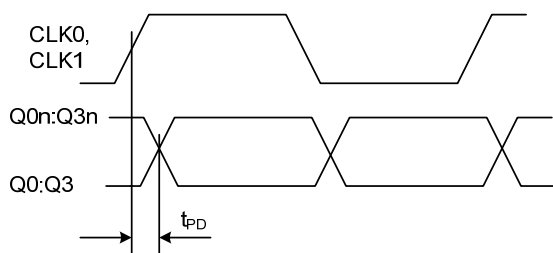
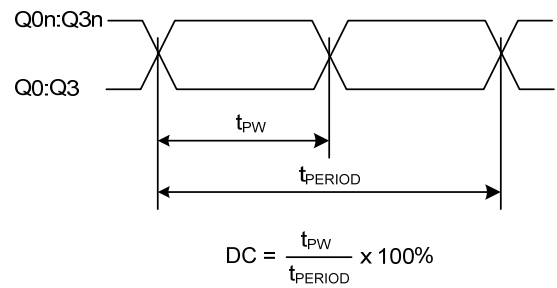
Parameter	Symbol	Conditions	MIN	TYP	MAX	Unit
Output Frequency	f _{OUT}				266	MHz
Propagation Delay ⁽¹⁾	t _{PD}		0.6		1.4	ns
Output Skew ⁽²⁾⁽³⁾	t _{sk(O)}				30	ps
Part-to-Part Skew ⁽³⁾⁽⁴⁾	t _{skPP}				200	ps
Buffer Additive Jitter, RMS	t _{jit}	12kHz to 20MHz		0.06		ps
Output Rise/Fall Time	t _r , t _f	20% to 80%	200		600	ps
Output Duty Cycle	DC _{OUT}		48	50	52	%

(1) Measured from the VDD/2 of the input to the differential output crossing point.

(2) Defined as skew between outputs at the same supply voltage and with equal load conditions.

(3) This parameter is defined in accordance with JEDEC Standard 65.

(4) Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.


Figure 1 3.3V Output Load Test Circuit

Figure 2 Part-to-Part Skew

Figure 3 Output Skew

Figure 4 Output Rise/Fall Time

Figure 5 Propagation Delay

Figure 6 Output Duty/ Pulse Width/ Period

Function Table

The following table shows the inputs/outputs clock state configured through the control pins.

Table 1: Control Input Function Table

Inputs			Outputs	
CLK_EN	CLK_SEL	Selected Source	Q0:Q3	Q0n:Q3n
0	0	CLK0	Disabled: Low	Disabled: High
0	1	CLK1	Disabled: Low	Disabled: High
1	0	CLK0	Enabled	Enabled
1	1	CLK1	Enabled	Enabled

After CLK_EN switches, the clock outputs are disabled or enabled following a rising and falling input clock edge as shown in Figure 7. In the active mode, the state of the outputs is a function of the CLK0 and CLK1 as described in Table 2.

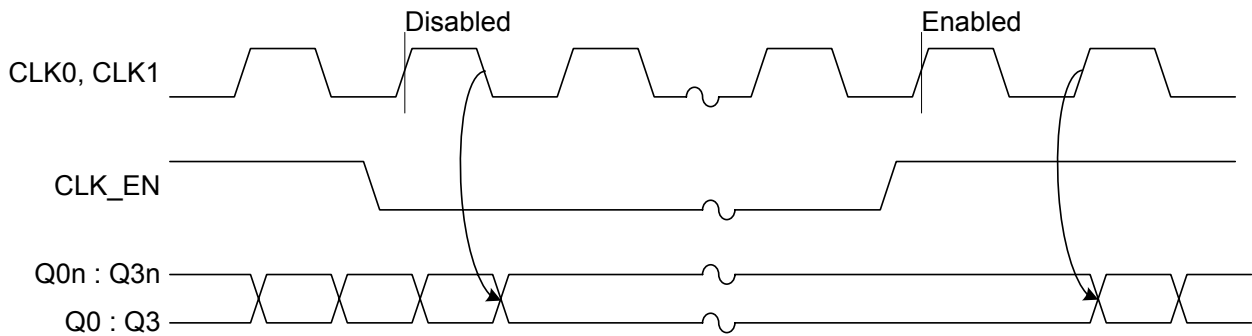
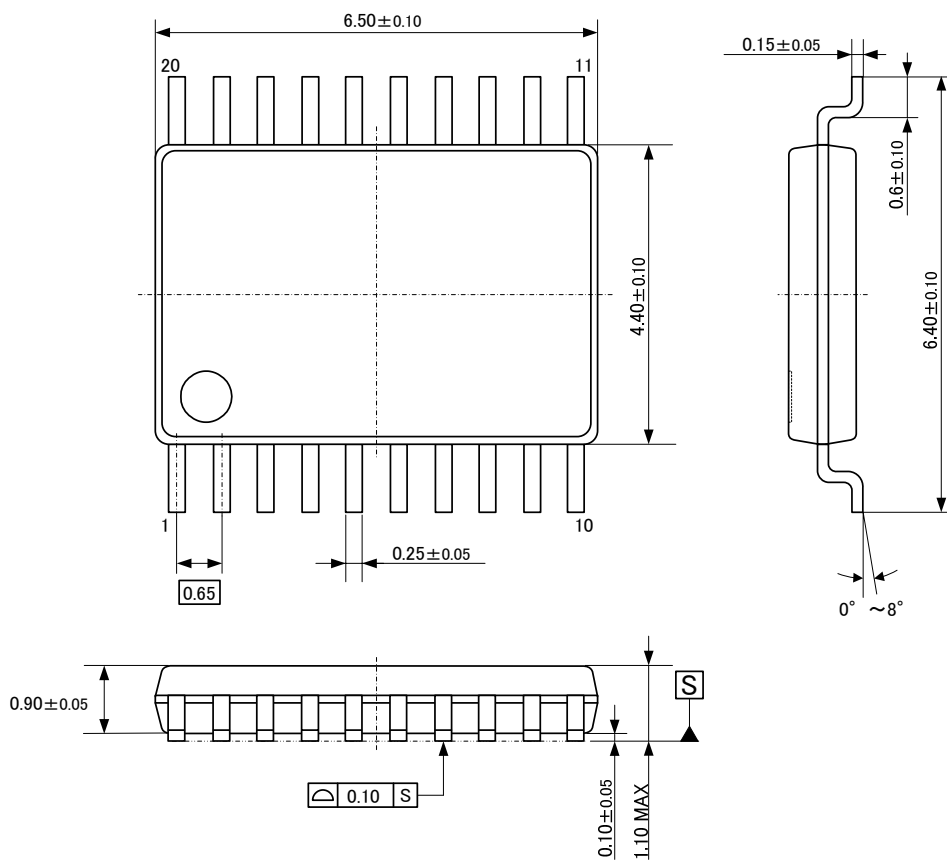
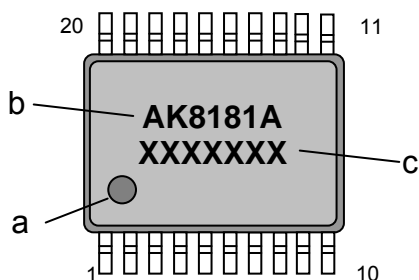


Figure 7 CLK_EN Timing Diagram

Table 2 Clock Input Function Table

Inputs	Outputs	
CLK0 or CLK1	Q0 : Q3	Q0n : Q3n
0	Low	High
1	High	Low

Package Information
• Mechanical data : 20pin TSSOP

• Marking


- a: #1 Pin Index
- b: Part number
- c: Date code (7 digits)

• RoHS Compliance


All integrated circuits from Asahi Kasei Microdevices Corporation (AKM) assembled in "lead-free" packages* are fully compliant with RoHS.

(* RoHS compliant products from AKM are identified with "Pb free" letter indication on product label posted on the anti-shield bag and boxes.

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